	JC03 Rec'd PCT/PTO 0 2 FFB 2001								2001	
Sheet 1 of 1										
FORM PTO 1449 (A		MENT OF COMMER	CE	ATTY DOCKET NO. 2001_0094A SERIAL NO. 09/762100**						
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)				APPLICANT Takatomo SASAKI et al.						
(Use several sheets if necessary)  Date Submitted to PTO: February 2, 2001				FILING DATE 7 GROUP February 2, 2001						
U.S. PATENT DOCUMENTS										
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS		SUBCLASS	FILING DATE IF APPROPRIATE		
	АА									
: \	АВ									
FOREIGN PATENT DOCUMENTS										
		DOCUMENT NUMBER	DATE	COUNTRY	CLA	ss	SUBCLASS	TRANS YES	LATION NO	
13.	AC	8-54656	2/1996	Japan				$\sim$	V	
	AD									
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)										
X	ΑĒ	ZHANG-GUI HU et al., Proceedings of SPIE - The International Society for Optical Engineering, Vol. 3556, pages 156-161, September, 1998								
13	AF	NING YE et al., Proceedings of SPIE - The International Society for Optical Engineering, Vol. 3556, pages 21-23, September, 1998								
by	AG `	ZHANG-GUI HU et al., Japanese Journal of Applied Physics, Part 2, Vol. 37, No. 10A, pages L1093-L1094, October, 1998								
3>	АН	KOZHINA et al., Vestn. Leningr. Univ., Fiz., Khim., No. 3, pages 40-46, 1983								
15	AI	CHEN et al., Proceedings of SPIE - The International Society for Optical Engineering, Vol. 3556, pages 14-20, September, 1998								
89	AJ	MORI et al., The Review of Laser Engineering, Vol. 26, No. 3, pages 215-219, March, 1998								
45	AK,	CHEN et al., Nature, Vol. 373, No. 6512, pages 322-324, 1995								
13	AL .	CHEN et al., Journal of Applied Physics, Vol. 77, No. 6, pages 2268-2272, 1995								

EXAMINER JEFFUNT

DATE CONSIDERED 3/3/63

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.